

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10614542	CHEN, SHIWEN
	<b>Examiner</b>	<b>Art Unit</b>
	Widhalm, Angela	2152

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consult comments presented by previous examiner and applicant; Review previously used prior art	07/10/2006	AMW
Consult with B.Jaroenchonwanit, T.Swann	07/11/2006	AMW
Telephone Interview with Applicant	07/12/2006	AMW
Update EAST search	08/04/2006	AMW
Update EAST Search	3/6/2007	AMW
Consult with V.Lesniewski	3/13/2007	AMW
Consult with K.Lin, V.Lesniewski	3/15/2007	AMW
Consult with B.Jaroenchonwanit	8/22/2007	AMW
Update EAST Search	8/29/2007	AMW
Update EAST search	3/10/2008	AMW
Consult with K.Lin, B.Jaroenchonwanit	3/20/2008	AMW
search assistance - A.Choudhury	3/20/2008	AMW

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>